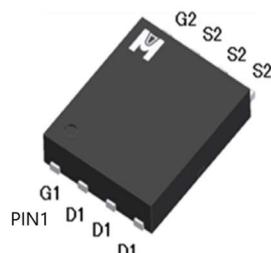
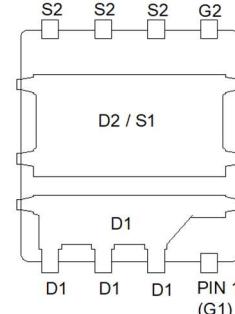
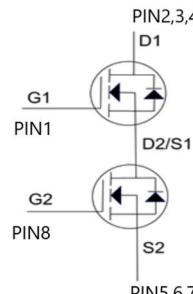


### N-Channel Logic Level Enhancement Mode Field Effect Transistor

#### Product Summary:

	N-CH-Q1	N-CH-Q2
BV <sub>DSS</sub>	30V	30V
R <sub>DSON</sub> (MAX.)	5.7mΩ	2.2mΩ
I <sub>D</sub>	48A	90A



N Channel MOSFET

UIS, Rg 100% Tested

Pb-Free Lead Plating & Halogen Free



#### ABSOLUTE MAXIMUM RATINGS (T<sub>A</sub> = 25 °C Unless Otherwise Noted)

PARAMETERS/TEST CONDITIONS	SYMBOL	LIMITS		UNIT
		Q1	Q2	
Gate-Source Voltage	V <sub>GS</sub>	±20	±12	V
Continuous Drain Current	I <sub>D</sub>	48	90	A
		18	29	
		14	23	
		30	57	
Pulsed Drain Current <sup>1</sup>	I <sub>DM</sub>	100	250	
Avalanche Current	I <sub>AS</sub>	35	60	
Avalanche Energy	E <sub>AS</sub>	61	180	mJ
Repetitive Avalanche Energy <sup>2</sup>	E <sub>AR</sub>	30	90	
Power Dissipation	P <sub>D</sub>	21	40	W
		8	16	
Operating Junction & Storage Temperature Range	T <sub>j</sub> , T <sub>stg</sub>	-55 to 150		°C

100% UIS testing in condition of Q1 V<sub>D</sub>=25V, L=0.1mH, V<sub>G</sub>=10V, I<sub>L</sub>=20A, Rated V<sub>DS</sub>=30V N-CH

100% UIS testing in condition of Q2 V<sub>D</sub>=25V, L=0.1mH, V<sub>G</sub>=10V, I<sub>L</sub>=38A, Rated V<sub>DS</sub>=30V N-CH

#### THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE	SYMBOL		TYPICAL	MAXIMUM		UNIT
Junction-to-Case	R <sub>θJC</sub>	Steady State	t ≤ 10 s	5.8	3.1	°C / W
Junction-to-Ambient	R <sub>θJA</sub>	Steady State		65	65	
	R <sub>θJA</sub>	t ≤ 10 s		40	40	

<sup>1</sup>Pulse width limited by maximum junction temperature.

<sup>2</sup>Duty cycle  $\leq 1\%$

$R_{0JA}$  when mounted on a 1 in<sup>2</sup> pad of 2 oz copper.

### ELECTRICAL CHARACTERISTICS ( $T_J = 25^\circ C$ , Unless Otherwise Noted)

PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNIT	
			MIN	TYP	MAX		
STATIC							
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = 250\mu A$	Q1	30		V	
			Q2	30			
Gate Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\mu A$	Q1	1	1.5	3	
			Q2	1	1.5	3	
Gate-Body Leakage	$I_{GSS}$	$V_{DS} = 0V, V_{GS} = \pm 20V$	Q1			$\pm 100$	
		$V_{DS} = 0V, V_{GS} = \pm 12V$	Q2			$\pm 100$	
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 24V, V_{GS} = 0V$	Q1			1	
			Q2			1	
		$V_{DS} = 20V, V_{GS} = 0V, T_J = 125^\circ C$	Q1			25	
			Q2			25	
On-State Drain Current <sup>1</sup>	$I_{D(ON)}$	$V_{DS} = 10V, V_{GS} = 10V$	Q1	48		A	
			Q2	90			
Drain-Source On-State Resistance <sup>1</sup>	$R_{DS(on)}$	$V_{GS} = 10V, I_D = 20A$	Q1		5.0	5.7	
		$V_{GS} = 10V, I_D = 20A$	Q2		1.8	2.2	
		$V_{GS} = 4.5V, I_D = 20A$	Q1		7.0	8.8	
		$V_{GS} = 4.5V, I_D = 20A$	Q2		2.6	3.4	
Forward Transconductance <sup>1</sup>	$g_{fs}$	$V_{DS} = 5V, I_D = 20A$	Q1		48	S	
		$V_{DS} = 5V, I_D = 20A$	Q2		72		
DYNAMIC							
Input Capacitance	$C_{iss}$	$V_{GS} = 0V, V_{DS} = 15V, f = 1MHz$	Q1		1327	pF	
			Q2		3770		
Output Capacitance	$C_{oss}$		Q1		430		
			Q2		1122		
Reverse Transfer Capacitance	$C_{rss}$		Q1		37		
			Q2		82		
Gate Resistance	$R_g$	$V_{GS} = 15mV, V_{DS} = 0V, f = 1MHz$	Q1		1.1	$\Omega$	
			Q2		1.3		

Total Gate Charge <sup>1,2</sup>	$Q_g(V_{GS}=10V)$	$V_{DD} = 15V, V_{GS} = 10V, I_D = 20A$	Q1		22		nC
	$Q_g(V_{GS}=4.5V)$		Q2		56		
			Q1		11		
			Q2		26		
Gate-Source Charge <sup>1,2</sup>	$Q_{gs}$	$V_{DD} = 15V, V_{GS} = 10V, I_D = 20A$	Q1		3		nS
			Q2		7.1		
Gate-Drain Charge <sup>1,2</sup>	$Q_{gd}$		Q1		4.3		
			Q2		8.8		
Turn-On Delay Time <sup>1,2</sup>	$t_{d(on)}$	$V_{DD} = 15V, I_D = 1A, V_{GS} = 10V, R_{GS} = 2.7\Omega$	Q1		15		nS
			Q2		20		
Rise Time <sup>1,2</sup>	$t_r$		Q1		15		
			Q2		20		
Turn-Off Delay Time <sup>1,2</sup>	$t_{d(off)}$		Q1		40		
			Q2		60		
Fall Time <sup>1,2</sup>	$t_f$		Q1		15		
			Q2		20		
<b>SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS (<math>T_J = 25^\circ C</math>)</b>							
Continuous Current	$I_S$		Q1			20	A
			Q2			30	
Pulsed Current <sup>3</sup>	$I_{SM}$		Q1			80	
			Q2			120	
Forward Voltage <sup>1</sup>	$V_{SD}$	$I_F = 10A, V_{GS} = 0V$	Q1			1.2	V
			Q2			1.2	
Reverse Recovery Time	$t_{rr}$	$I_F = 20A, dI_F/dt = 100A/\mu S$	Q1		30		nS
			Q2		35		
Reverse Recovery Charge	$Q_{rr}$		Q1		18		nC
			Q2		25		

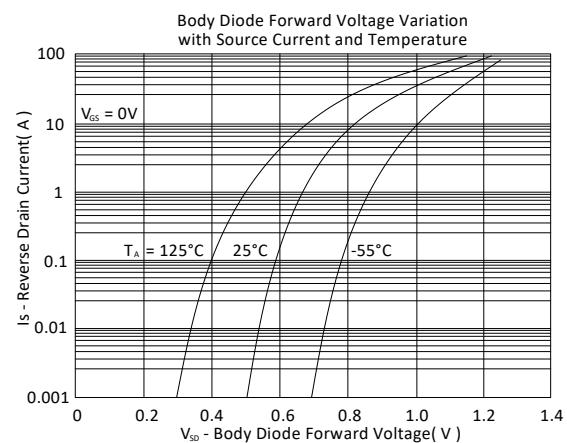
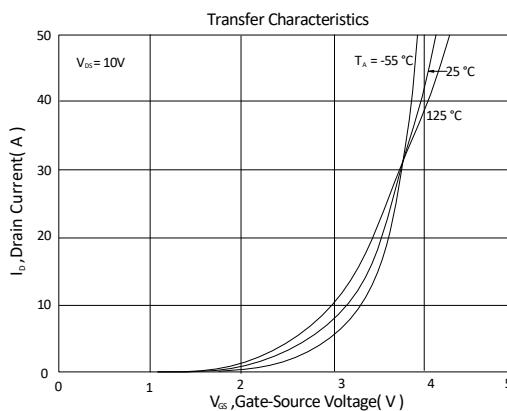
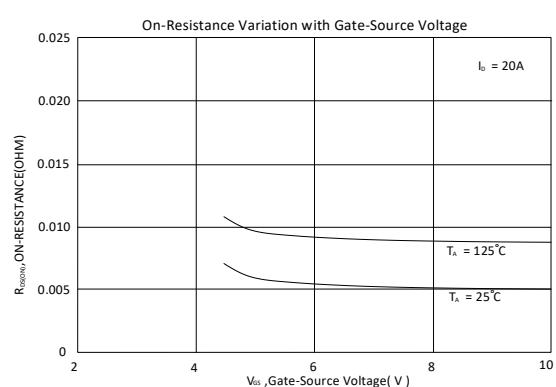
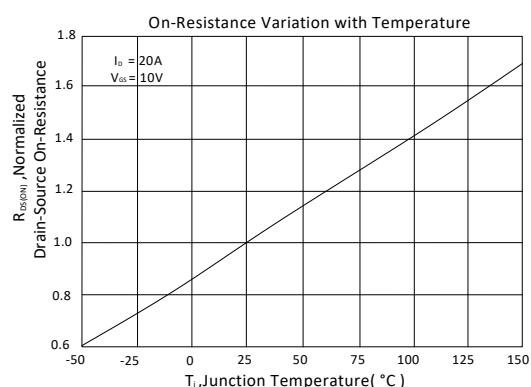
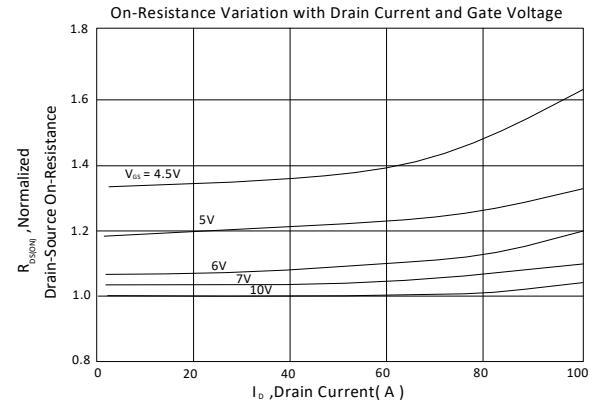
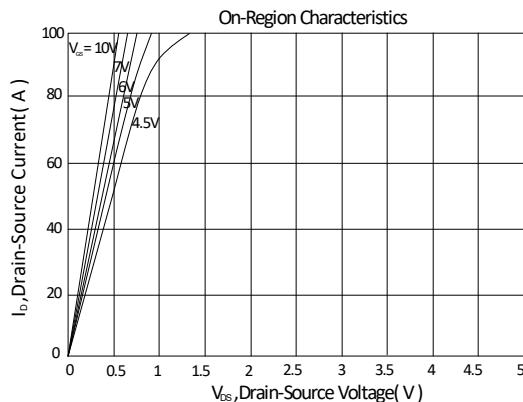
<sup>1</sup>Pulse test : Pulse Width  $\leq 300 \mu sec$ , Duty Cycle  $\leq 2\%$ .

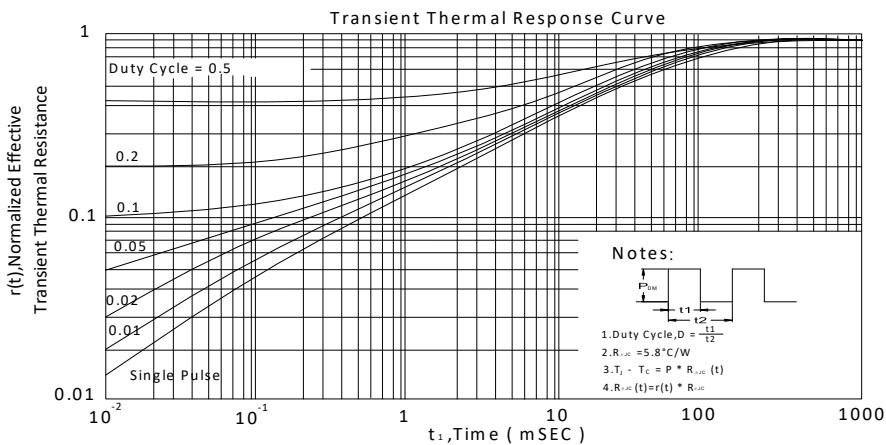
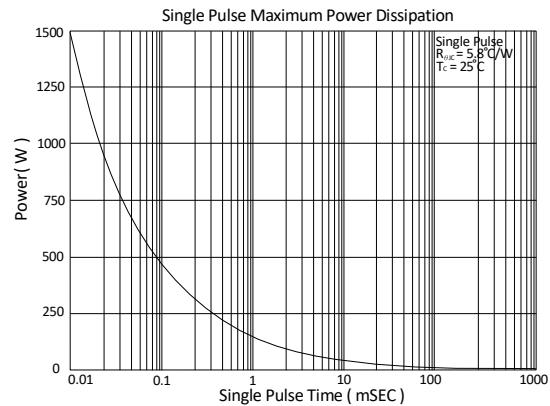
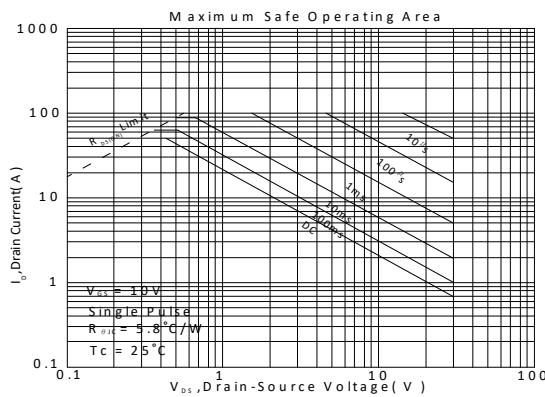
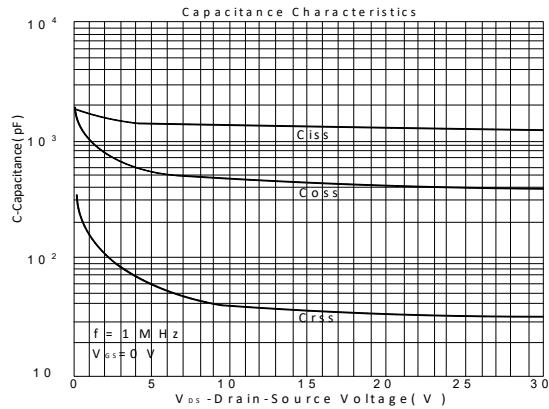
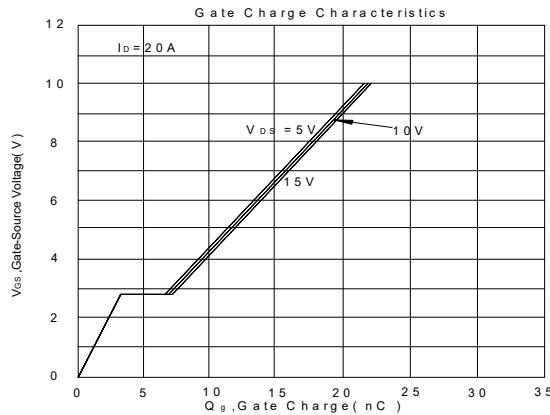
<sup>2</sup>Independent of operating temperature.

<sup>3</sup>Pulse width limited by maximum junction temperature.

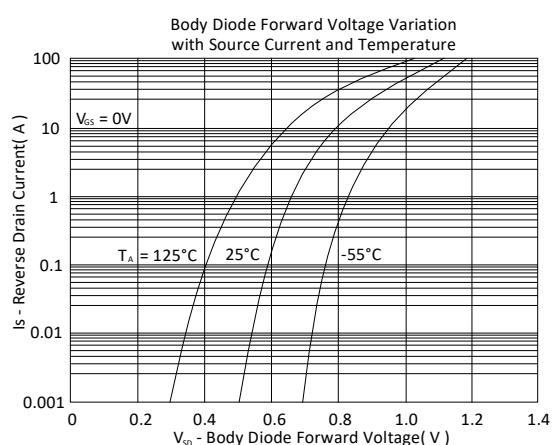
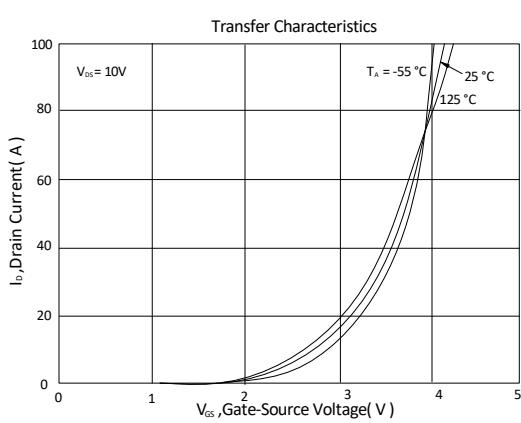
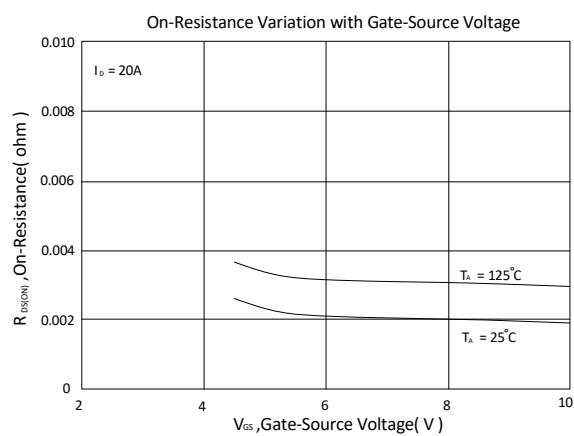
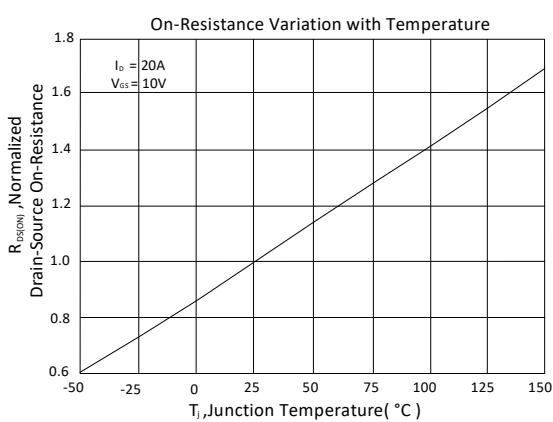
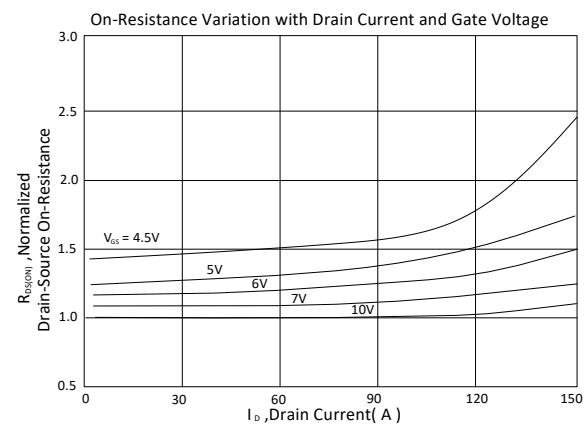
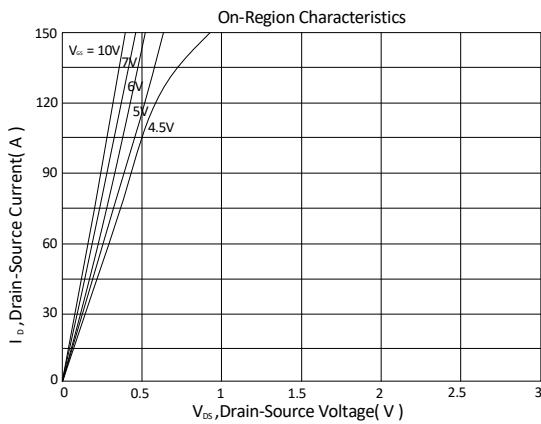
EMC will review datasheet by quarter, and update new version.

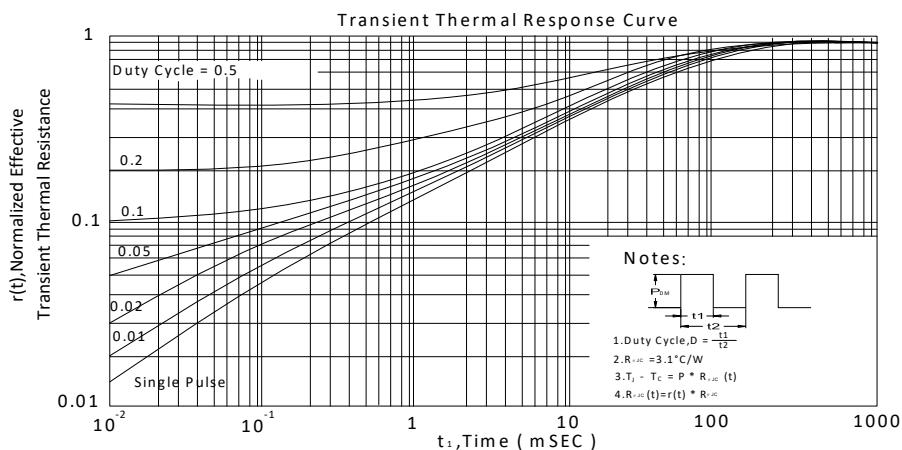
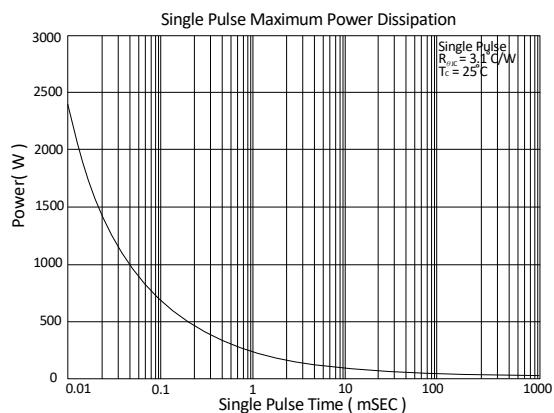
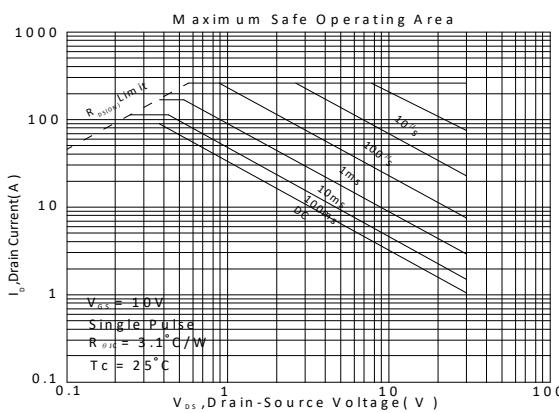
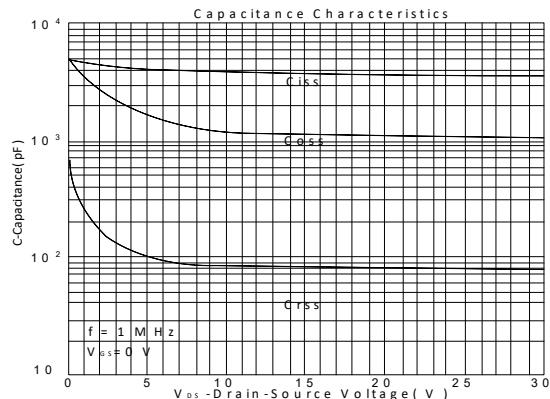
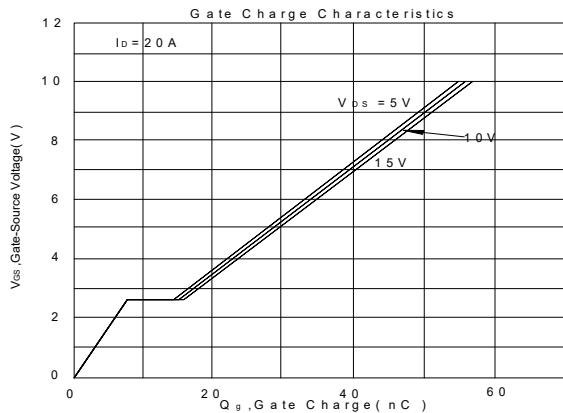
## Q1 TYPICAL CHARACTERISTICS





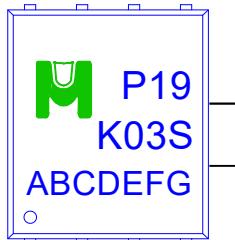
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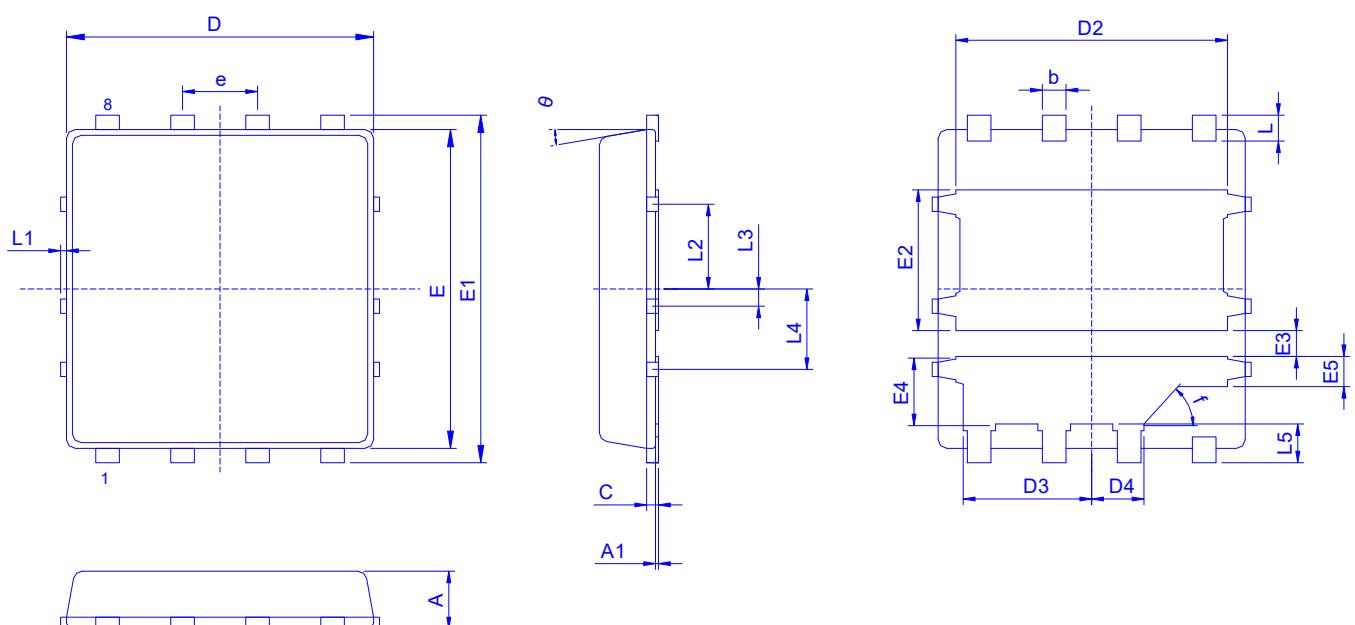
### Ordering & Marking Information

Device Name: EMP19K03HPCS for Asymmetric Dual EDFN5X6



- EMP19K03HPCS: Device Name
- ABCDEFG: Date Code
- A: Assembly House
- B: Year(A:2008 B:2009 C:2010....)
- C: Month(A:01 B:02 C:03 D:04 E:05 F:06 G:07 H:08 I:09 J:10 K:11 L:12)
- DEFG: Serial No.

### Outline Drawing



Dimension in mm

Dimension	A	A1	b	c	D	D2	D3	D4	E	E1	E2	E3	E4	E5
Min.	0.85	0.00	0.35	0.15		4.5	2.125	0.835			2.4	0.40	1.125	0.475
Typ.	0.90		0.40	0.20	5.2	4.6	2.175	0.885	5.55	6.05	2.45	0.45	1.175	0.525
Max.	1.00	0.05	0.45	0.25		4.7	2.225	0.935			2.5	0.50	1.225	0.575

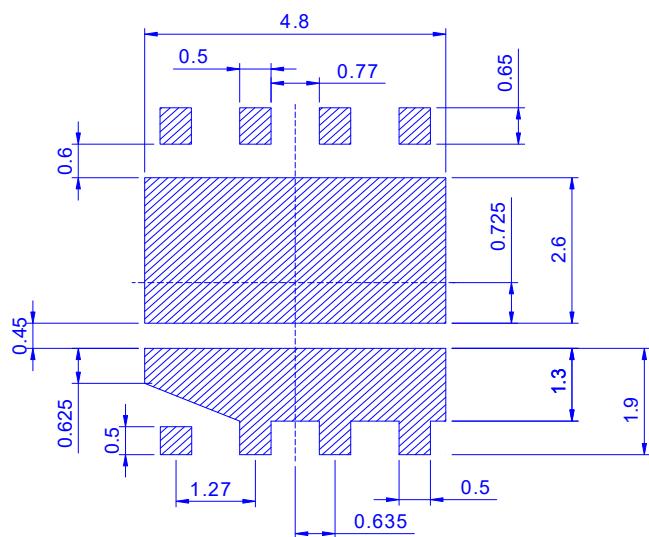
Dimension	e	L	L1	L2	L3	L4	L5	F	θ
Min.		0.35	0	1.375	0.2	1.3	0.575		0°
Typ.	1.27	0.45		1.475	0.3	1.4	0.675	45°	
Max.		0.55	0.1	1.575	0.4	1.5	0.775		10°



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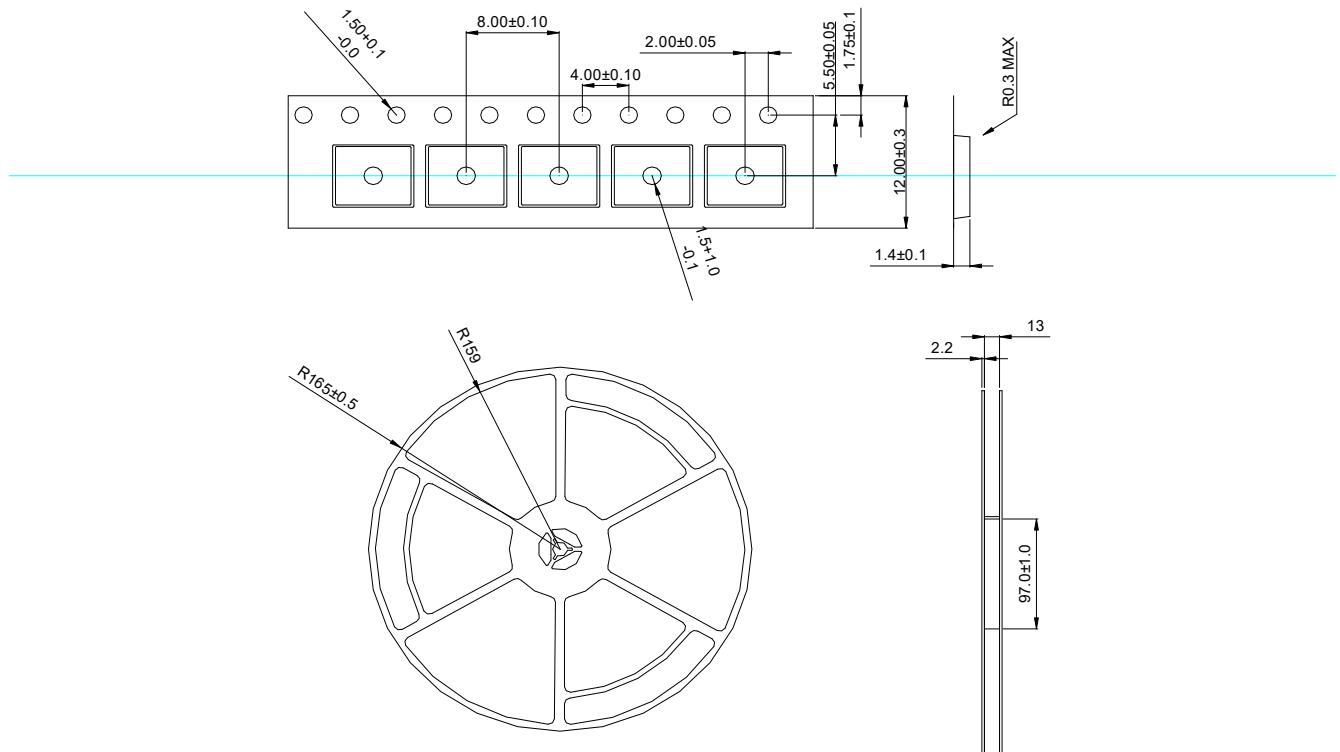
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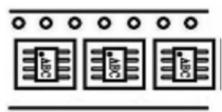
Recommended minimum pads





◆ Tape&Reel Information: 2500pcs/Reel(Dimension in millimeter)



產品別	EDFN5X6
Reel 尺寸	13"
編帶方式	FEED DIRECTION  
前空格	25
後空格	50
裝箱數	
滿捲數量	2.5K
捲/內盒比	1 : 1
內盒滿箱數	2.5K
內/外箱比	10 : 1
外箱滿箱數	25K